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1. General information's

1-1 Test Performed

Company name : LTA Co., Ltd.
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 Facsimile : +82-31-323-6010

Quality control in the testing laboratory is implemented as per ISO/IEC 17025 which is the “General requirements for the competents of calibration and testing laboratory”.

1-2 Accredited agencies

LTA Co., Ltd. is approved to perform EMC testing by the following agencies:

Agency	Country	Accreditation No.	Validity	Reference
NVLAP	U.S.A	200723-0	2013-09-30	ECT accredited Lab.
RRA	KOREA	KR0049	UPDATING	EMC accredited Lab.
FCC	U.S.A	610755	2014-04-27	FCC filing
FCC	U.S.A	649054	UPDATING	FCC CAB
VCCI	JAPAN	R2133(10 m), C2307	2014-06-21	VCCI registration
VCCI	JAPAN	T-2009	2013-12-23	VCCI registration
VCCI	JAPAN	G-563	2015-05-28	VCCI registration
IC	CANADA	IC5799	2015-06-21	IC filing

2. Information's about test item

2-1 Client / Manufacturer

Company name : HANSHIN INFORMATION TECHNOLOGY Co.,Ltd.
 Address : (305-510) 201, IT Venture Tower, 694 Taprip-Dong,
 Yuseong-Gu, Daejeon, Korea
 Telephone / Facsimile : +82-42-933-8507 / +82-42-933-8509

2-2 Manufacturer

Company name : HANSHIN INFORMATION TECHNOLOGY Co.,Ltd.
 Address : (305-510) 201, IT Venture Tower, 694 Taprip-Dong,
 Yuseong-Gu, Daejeon, Korea
 Telephone / Facsimile : +82-42-933-8507 / +82-42-933-8509

2-3 Equipment Under Test (EUT)

Trade name : 
 Model name : HS6618A
 Serial number : Identical prototype
 Date of receipt : March 20, 2013
 EUT condition : Pre-production, not damaged
 Antenna type : Patch Antenna with Max Gain: 2.5 dBi
 Frequency Range : 6336 ~ 7920MHz
 RF output power : Max -25.19 dBm – EIRP
 Type of Modulation : OFDM
 Power Source : DC 5V by USB Power
 Firmware Version : V1.0.0

2-4 Tested Condition

Temperature	: +(15-35) °C	Operating mode	: Wireless mode
Humidity	: (30 – 65) %RH	Power supply	: 230 Vac, 50Hz
Pressure	: (880 – 930) mbar		

2-5 Ancillary Equipment

Equipment	Model No.	Serial No.	Manufacturer
PRINTER	STYLUS C65	FXSY002205	EPSON
NoteBook	PP37L	G4YRDN1	DELL
TV monitor	M2352D	ME264385301	LG
HD Display Kit	N/A	N/A	N/A

3. Test Report

3.1 Summary of tests

Reference	Parameter	Status (note)
I. Emission		
Radiated Emission	EN 55022:2010	C ^{note3}
Conducted Emission (DC port)	EN 55022:2010	NA
Conducted Emission (AC port)	EN 55022:2010	C
Harmonic Current Emission (AC port)	EN 61000-3-2:2006+A2:2009	NA ^{note1}
Voltage Fluctuations and Flicker (AC port)	EN 61000-3-3:2008	NA ^{note2}
Conducted Emission (Telecommunication port)	EN 55022:2010	NA
II. Immunity		
RF Electromagnetic field (80 MHz to 2.7 GHz)	EN 61000-4-3:2006+A2 :2010	C
Electrostatic Discharge	EN 61000-4-2:2009	C
Fast Transients Common mode	EN 61000-4-4:2004+A1:2010	C
RF common mode 0,15 MHz to 80 MHz	EN 61000-4-6:2009	C
Voltage dips and Interruptions	EN 61000-4-11:2004	C
Surges, line to line and line to ground	EN 61000-4-5:2006	C
C=Complies NC=Not Complies NA=Not Applicable		

Note 1 We did not test EN61000-3-2 (Harmonic current emissions) for the **HS6618A** because equipment whose rated power is less or equal 75W don't need to be tested.

Note 2 We did not test EN 61000-3-3 (Flicker) for the **HS6618A** because of clause 6.1, this standard Predicate as follows: "Devices which produce no significant voltage dips or flicker with a certain probability have not to be tested."

Note 3 The highest internal source of an EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less. (The highest internal source of an EUT: 8.976 GHz)

Note 4 The sample was tested according to the following specification:

ETSI Standards; ETSI EN 301 489-1 V1.9.2(2013.06), ETSI EN 301 489-17 V2.1.1 (2009.05)

3.2 EMISSION

3.2.1 Radiated Emission

Definition:

The test assesses the ability of ancillary equipment to limit their internal noise from being radiated from the enclosure.
We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 55022:2006+A2:2010
Measuring Distance	: 10 m for below 1 GHz / 3 m for above 1 GHz
Measurement Frequency range	: 30 MHz – 6 000 MHz
Measurement RBW	: 120 kHz @ 10 m / 1 MHz @ 3 m
Test mode	: Wireless mode
Result	: Complies

Measurement Data:

→ **Refer to the Next page** (Maximum emission configuration)

→ No other emissions were detected at a level greater than 20 dB below limit.

- The highest internal source of an EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less. (The highest internal source of an EUT: 8.976 GHz)

Limit:

CLASS A

Frequency Range	EN 55022 @ 10 m (Quasi-peak)
(30 – 230) MHz	40 dB μ V/m
(230 – 1 000) MHz	47 dB μ V/m
NOTE:	The lower limit applies at the transition frequency.

CLASS B

Frequency Range	EN 55022 @ 10 m (Quasi-peak)
(30 – 230) MHz	30 dB μ V/m
(230 – 1 000) MHz	37 dB μ V/m
NOTE:	The lower limit applies at the transition frequency.

CLASS A

Frequency Range	Average Limit @ 3 m (dB μ V/m)	Peak limit @ 3 m (dB μ V/m)
(1 000 – 3 000) MHz	56	76
(3 000 – 6 000) MHz	76	80
NOTE:	The lower limit applies at the transition frequency.	

CLASS B

Frequency Range	Average Limit @ 3 m (dB μ V/m)	Peak limit @ 3 m (dB μ V/m)
(1 000 – 3 000) MHz	50	70
(3 000 – 6 000) MHz	54	74
NOTE:	The lower limit applies at the transition frequency.	

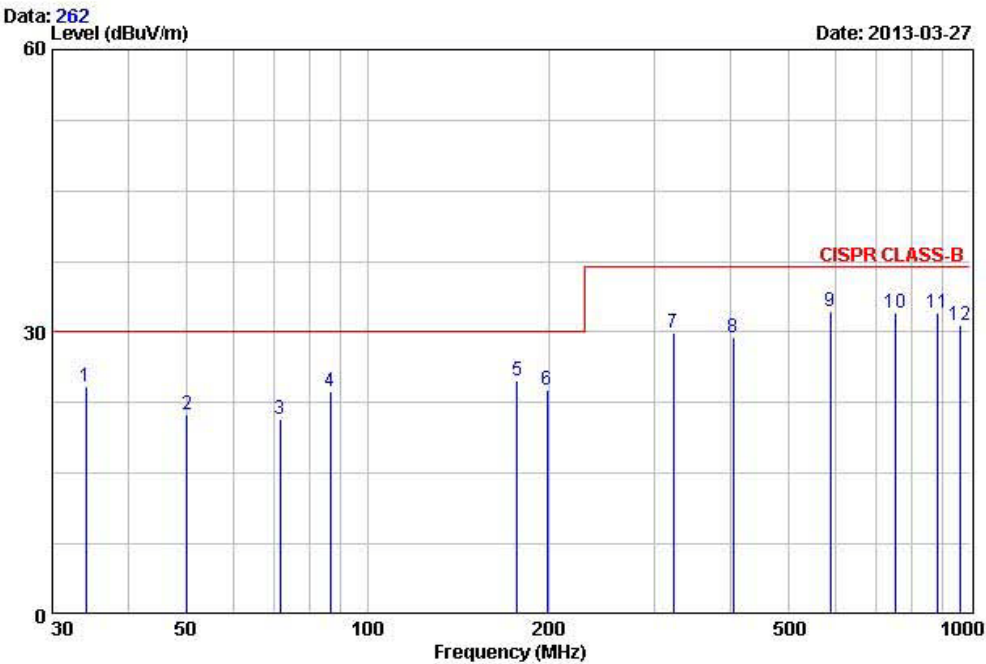
Measurement Data : Below 1 GHz



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EUT/Model No.: HS6618A TEST MODE: Wireless mode

Temp Humi : 11 / 23 Tested by: PARK H W



Freq	Reading	C.F	Result	Limit	Margin	Height	Angle	Polarity
MHz	dBuV/m	dB/m	dBuV/m	dBuV/m	dB	cm	deg	
1	34.12	-17.44	24.26	30.00	5.74	100	131	VERTICAL
2	50.13	-16.00	21.30	30.00	8.70	100	182	VERTICAL
3	71.74	-18.37	20.83	30.00	9.17	218	75	HORIZONTAL
4	86.70	-19.71	23.69	30.00	6.31	100	184	VERTICAL
5	177.42	-14.52	24.78	30.00	5.22	100	128	HORIZONTAL
6	198.84	-16.27	23.83	30.00	6.17	100	227	VERTICAL
7	321.71	-10.95	29.85	37.00	7.15	241	146	HORIZONTAL
8	405.36	-8.96	29.44	37.00	7.56	100	116	VERTICAL
9	586.14	-4.15	32.25	37.00	4.75	100	103	VERTICAL
10	753.12	-0.02	32.08	37.00	4.92	241	123	HORIZONTAL
11	884.31	2.33	32.03	37.00	4.97	100	109	VERTICAL
12	963.14	5.62	30.82	37.00	6.18	374	149	HORIZONTAL

Remarks: C.F (Correction Factor) = Antenna factor + Cable loss - Preamp gain

Measurement Data : Above 1 GHz

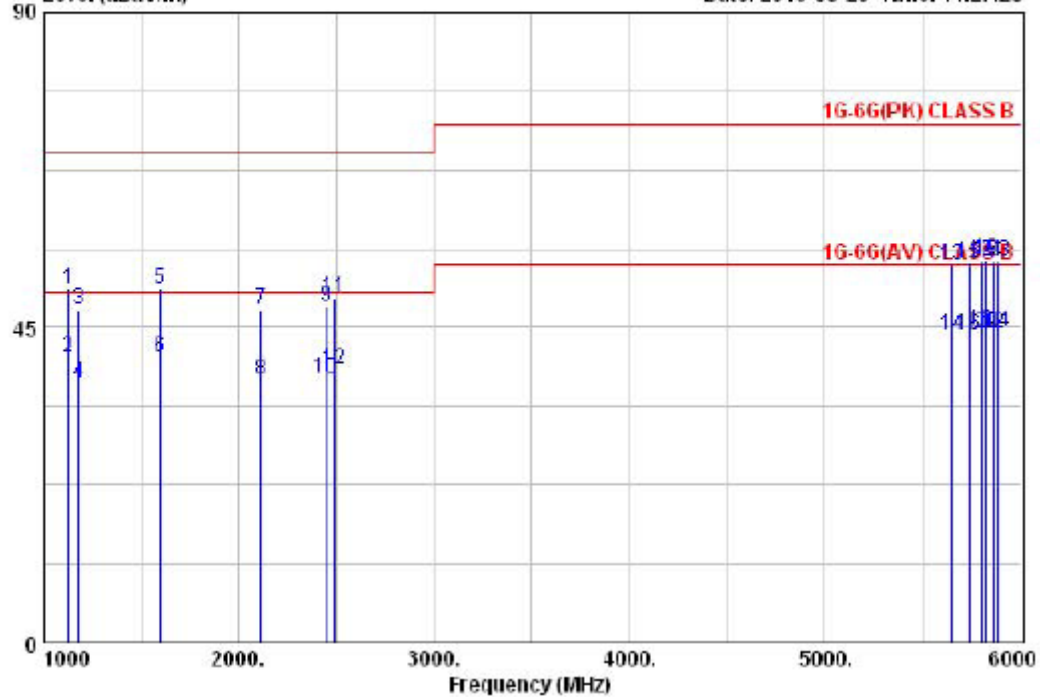
RUT/Model No. : HS6618A

Temp/Humi: 21 / 39

Test Mode : Wireless mode

Tested by: PARK H W

Data: 144 File: F:\EMI DATA\0_e3 data\ABOVE 1GHz\2013\LTA_ABOVE 1GHz_1303-1.EMI (144)
 Level (dBuV/m) Date: 2013-03-25 Time: 14:27:28



Manufacturer : HANSHIN INFORMATION TECHNOLOGY Co.,Ltd.

Test Date

Temp.:
[°C]Humidity:
[%]

Model : HS6618A

25-Mar-13

21

39

TEST mode : Wireless mode

Freq.(MHz)	Reading(PK)	Reading(AV)	C.F	Result(PK)	Result(AV)	Limit(PK)	Limit(AV)	Margin(PK)	Margin(AV)	Height	Angle	Polarity
MHz	dBuV	dBuV	dB	dBuV/m	dBuV/m	dBuV/m	dBuV/m	dB	dB	cm	deg	Hor/Ver
1123.5	60.2	50.2	-9.57	50.61	40.64	70.0	50.0	19.39	9.36	100	318	Hor
1179.2	56.7	46.2	-9.08	47.59	37.15			22.41	12.85	100	248	Hor
1599.1	57.2	47.2	-6.61	50.56	40.59			19.44	9.41	100	156	Ver
2114.2	50.3	40.1	-2.7	47.64	37.44			22.36	12.56	100	73	Ver
2449.5	50.3	40.1	-2.4	47.94	37.70			22.06	12.30	100	187	Ver
2489.3	51.5	41.3	-2.31	49.19	38.99			20.81	11.01	100	121	Ver
5645.4	44.1	34.1	9.88	54.02	44.00	74.0	54.0	19.98	10.00	100	318	Ver
5737.2	43.8	33.5	10.39	54.18	43.89			19.82	10.11	100	248	Hor
5799.2	43.8	33.9	10.72	54.56	44.62			19.44	9.38	100	156	Hor
5820.0	43.8	33.4	10.82	54.63	44.22			19.37	9.78	100	73	Hor
5861.9	43.3	33.1	11.04	54.34	44.14			19.66	9.86	100	187	Ver
5882.9	43.2	33.2	11.15	54.35	44.35			19.65	9.65	100	121	Ver

3.2.2 Conducted emissions (AC Power In/Output port)

Definition:

The test assesses the ability of the EUT to limit its internal noise from being present on the AC mains Power In/Output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 55022:2006+A2:2010
Measurement Frequency range	: 150 kHz – 30 MHz
Measurement RBW	: 9 kHz
Test mode	: Wireless mode
Result	: Complies

Measurement Data:

- Refer to the Next page (Maximum emission configuration)
- No other emissions were detected at a level greater than 20 dB below limit.

Limit: Clause 8.3.3

Limits for conducted disturbance at the mains ports of class A ITE

Frequency Range	Quasi-peak	Average
(0.15 - 0.5) MHz	79 dB μ V	66 dB μ V
(0.5 – 30) MHz	73 dB μ V	60 dB μ V

Note: The limits will decrease with the frequency logarithmically within 0.15MHz to 0.5MHz

Limits for conducted disturbance at the mains ports of class B ITE

Frequency Range	Quasi-peak	Average
(0.15 - 0.5) MHz	(66 – 56) dB μ V	(56 – 46) dB μ V
(0.5 – 5) MHz	56 dB μ V	46 dB μ V
(5 – 30) MHz	60 dB μ V	50 dB μ V

Note: The limits will decrease with the frequency logarithmically within 0.15 MHz to 0.5 MHz

TEST EQUIPMENT USED: 02, 03, 05, 22, 32, 38, 41, 43, 44, 45, 60

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class A equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 - 0.5) MHz	(97 – 87) dB μ V	(84 – 74) dB μ V	(53 – 43) dB μ V	(40 – 30) dB μ V
(0.5 – 30) MHz	87 dB μ V	74 dB μ V	43 dB μ V	30 dB μ V

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150 Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz for class B equipment

Frequency Range	Voltage limits		Current limits	
	Quasi-peak	Average	Quasi-peak	Average
(0.15 - 0.5) MHz	(84 – 74) dB μ V	(74 – 64) dB μ V	(40 – 30)dB μ V	(30 – 20) dB μ V
(0.5 – 30) MHz	74 dB μ V	64 dB μ V	30 dB μ V	20 dB μ V

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150 Ω to the telecommunication port under test (conversion factor is $20 \log_{10} 150/I = 44$ dB)

TEST EQUIPMENT USED: 02, 03, 05, 22, 32, 38, 41, 43, 44, 45, 60

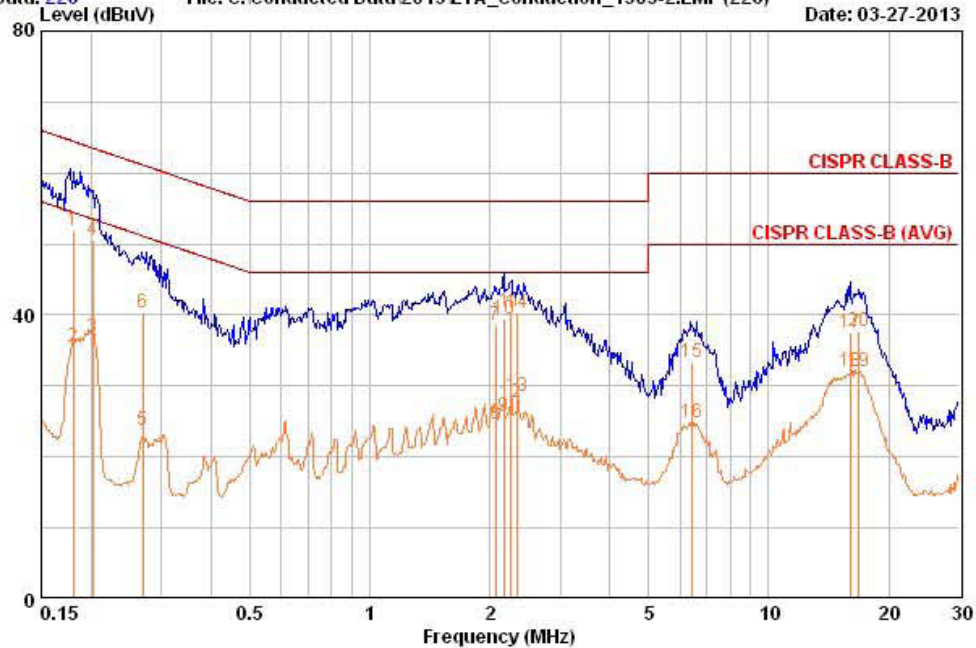
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EUT / Model No. : HS6618A	Phase : LINE
Test Mode : Wireless mode	Test Power : 230 / 50
Temp./Humi. : 22 / 41	Test Engineer : PARK H W

Data: 226 File: C:\Conducted Data\2013\LTA_Conduction_1303-2.EMI (226) Date: 03-27-2013



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.180	42.25	25.95	9.60	51.85	35.55	64.49	54.49	12.64	18.94
0.202	41.05	27.15	9.58	50.63	36.73	63.53	53.53	12.90	16.80
0.270	30.66	14.16	9.59	40.25	23.75	61.12	51.12	20.87	27.37
2.064	28.99	14.99	9.69	38.68	24.68	56.00	46.00	17.32	21.32
2.166	29.79	15.99	9.69	39.48	25.68	56.00	46.00	16.52	20.32
2.252	30.78	17.88	9.69	40.48	27.58	56.00	46.00	15.52	18.42
2.344	30.68	18.88	9.69	40.37	28.57	56.00	46.00	15.63	17.43
6.420	23.67	15.27	9.67	33.34	24.94	60.00	50.00	26.66	25.06
16.040	27.61	22.21	9.89	37.49	32.09	60.00	50.00	22.51	17.91
16.840	27.91	22.21	9.89	37.80	32.10	60.00	50.00	22.20	17.90

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss

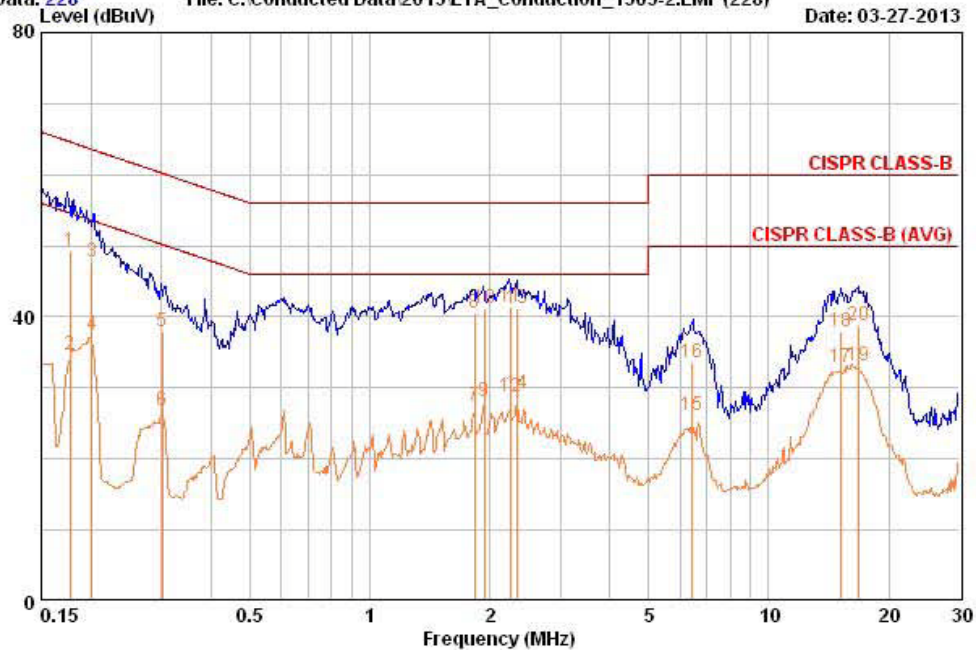
NEUTRAL:



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Tel :+82-31-3236008,9
Fax:+82-31-3236010

EUT / Model No. : HS6618A	Phase : NEUTRAL
Test Mode : Wireless mode	Test Power : 230 / 50
Temp./Humi. : 22 / 41	Test Engineer : PARK H W

Data: 228 File: C:\Conducted Data\2013\LTA_Conduction_1303-2.EMI (228) Date: 03-27-2013



Freq	RD	RD	C.F	Result	Result	Limit	Limit	Margin	Margin
MHz	QP	AV	dB	QP	AV	QP	AV	QP	AV
	dBuV	dBuV		dBuV	dBuV	dBuV	dBuV	dB	dB
0.177	39.65	25.15	9.59	49.24	34.74	64.63	54.63	15.38	19.88
0.201	38.15	27.85	9.57	47.72	37.42	63.57	53.57	15.85	16.15
0.301	28.45	17.15	9.59	38.04	26.74	60.22	50.22	22.18	23.48
1.835	30.89	17.69	9.67	40.56	27.36	56.00	46.00	15.44	18.64
1.938	31.49	18.49	9.68	41.17	28.17	56.00	46.00	14.83	17.83
2.246	31.68	18.98	9.69	41.37	28.67	56.00	46.00	14.63	17.33
2.348	31.58	19.58	9.68	41.27	29.27	56.00	46.00	14.73	16.73
6.419	23.87	16.37	9.68	33.55	26.05	60.00	50.00	26.45	23.95
15.210	28.00	22.90	9.93	37.94	32.84	60.00	50.00	22.06	17.16
16.730	28.81	23.21	9.96	38.77	33.17	60.00	50.00	21.23	16.83

Remarks: C.F (Correction Factor) = Insertion loss + Cable loss

3.2.3 Harmonic Current (AC power input port)

Definition:

This part deals with the Limitation of harmonic currents injected into the public supply system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-3-2:2006+A2:2009
Test mode	: -
Rated power	: - W max
Result	: Not Applicable

Measurement Data:

Note : We did not test EN61000-3-2 (Harmonic current emissions) for the **HS6618A** because equipment whose rated power is less or equal 75W don't need to be tested.

TEST EQUIPMENT USED: 33, 34, 38, 56, 60

3.2.4 Voltage Variation and Flicking (AC power input port)

Definition:

This section is concerned with the limitation of voltage fluctuations and flicker impressed on the public low-voltage system.

We were performed the test according to LTA procedure LTA-QI-04.

Test method : EN 61000-3-3:2008

Test mode : -

Result : **Not Applicable**

Measurement Data:

Note : We did not test EN 61000-3-3 (Flicker) for the **HS6618A** because of clause 6.1, this standard Predicate as follows: “Devices which produce no significant voltage dips or flicker with a certain probability have not to be tested.”

3.3 IMMUNITY

3.3.1 Radio Frequency Electromagnetic field (80 MHz to 1 GHz and 1.4 GHz to 2.7 GHz)

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic field disturbance.

Test method	: EN 61000-4-3:2006+A2:2010
Frequency range	: 80 MHz to 1 GHz and 1.4 GHz to 2.7 GHz
Test level	: 3 V/m (measured unmodulated)
Amplitude Modulation	: AM, 80 %, 1 kHz Audio signal
Step size	: 1 % of fundamental
Test mode	: Wireless mode
Result	: Complies (Performance Criteria: A)

Measurement Data:

Pol	Side	Remark
Horizontal	Front	No reaction recognized
	Left	No reaction recognized
	Rear	No reaction recognized
	Right	No reaction recognized
Vertical	Front	No reaction recognized
	Left	No reaction recognized
	Rear	No reaction recognized
	Right	No reaction recognized

TEST EQUIPMENT USED: 19, 25, 26, 27, 28, 29, 38, 55, 59

3.3.2 Electrostatic Discharge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of an electrostatic discharge.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-2:2009
Discharge Impedance	: (330 ±10%) Ω
	: (150 ±10%) pF
Type of Discharge (air discharge)	: ± 2 kV, ± 4 kV, ± 8 kV
Type of Discharge (contact discharge)	: ± 2 kV, ± 4 kV
Polarity of Output Voltage	: Positive and Negative
Number of discharges at each point	: 10 of each polarity
Discharge Repetition on Rate	: 1 / sec
Test mode	: Wireless mode
Result	: Complies (Performance Criteria: A)

Measurement Data:

1. Indirect Discharge

No.	Position	Kind of Discharge	Results	Remarks
①	HCP	Contact	Complies	No reaction recognized
②	VCP	Contact	Complies	No reaction recognized

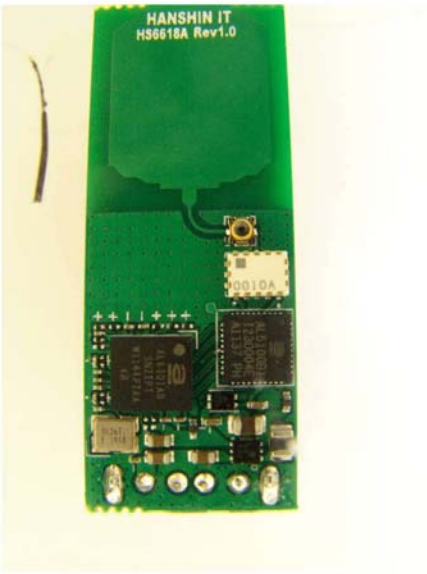
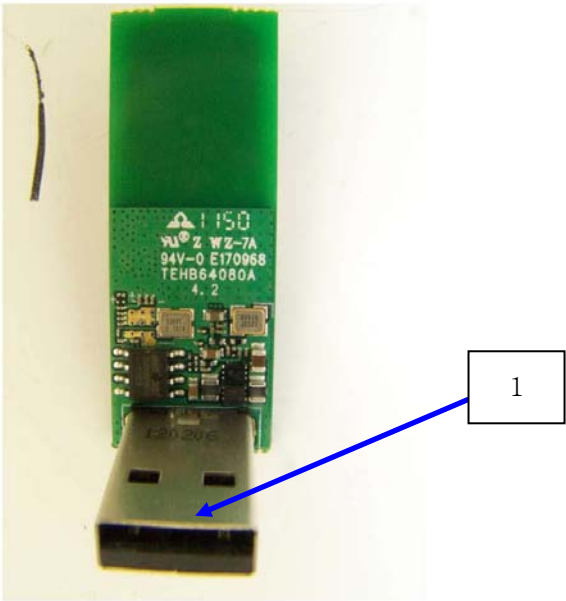
2. Direct Discharge

Position No.	Position	Kind of Discharge	Result	Remarks
①	USB	Air	Complies	No reaction recognized

TEST EQUIPMENT USED: 10, 38, 61

- ← Air discharge
- ← Contact discharge

ESD TEST POINT



3.3.3 Electric Fast Transient Pulse Group Immunity

Definition:

The test assesses the ability of the EUT to operate as intended in the event of fast transients presence on one of the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-4:2004+A1:2010
Cable length	: < 3 m
Test level	: 0.5 kV (Signal / Communication / Control ports / DC power input port) 1.0 kV (AC power input port)
Polarity	: Negative/ Positive
Repetition frequency	: 5 kHz
Test mode	: Wireless mode
Result	: Complies (Performance Criteria: A)

Measurement Data:

AC power Line	Test level	Result	Remarks
L - N	+ 1 kV	Complies	No reaction recognized
	- 1 kV	Complies	No reaction recognized

Signal Line	Test level	Result	Remarks
-	-	-	-
	-	-	-

TEST EQUIPMENT USED: 12, 38, 58, 61, 63

3.3.4 Radio Frequency, common mode

Definition:

The test assesses the ability of the EUT to operate as intended in the presence of a radio frequency electromagnetic disturbance on the input/output ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-6:2009
Cable length	: < 3 m
Frequency range	: 0.15 MHz – 80 MHz
Test level	: 3 Vrms unmodulated
Amplitude Modulation	: AM, 80 %, 1 kHz Audio signal
Step size	: 1 % of fundamental.
Test mode	: Wireless mode
Result	: Complies (Performance Criteria: A)

Measurement Data:

Port	Test mode	Result	Remarks
AC power	Wireless mode	Complies	No reaction recognized

TEST EQUIPMENT USED: 29, 30, 31, 38, 46, 54, 60

3.3.5 Voltage Dips and Interruption

Definition:

The test assesses the ability of the EUT to operate as intended in the event of voltage dips and interruptions present on the AC mains power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-11:2004
Voltage dip	: 0 % residual voltage for 0.5 cycle and 1 cycle 70 % residual voltage for 25 cycle
Voltage Interruption	: 0 % residual voltage for 250 cycle
Ut	: 230 Vac, 50Hz
Test mode	: Wireless mode
Result	: Complies

Measurement Data:


Test Level %Ut	Voltage droop and interruptions %Ut	Duration of Reduction (cycle)	Result	Remarks
0	>95	0.5	Complies	No reaction recognized
0	>95	1	Complies	No reaction recognized
70	30	25	Complies	During : EUT Power off After : Recoverable by user
0	>95	250	Complies	No reaction recognized

Performance Criteria:

- Criteria for voltage dips of 0.5,1 cycles duration: **B**.
- Criteria for voltage dips of 25 cycle and voltage interruptions of 250 cycle duration: **C**.

TEST EQUIPMENT USED: 11, 38, 47, 57, 61

3.3.6 Surge

Definition:

The test assesses the ability of the EUT to operate as intended in the event of surge presence on the AC main power input ports.

We were performed the test according to LTA procedure LTA-QI-04.

Test method	: EN 61000-4-5:2006
Test level	: 1.0 kV (line to line) 2.0 kV (line to ground)
Polarity	: Negative/ Positive
Wave shape	: 1,2 / 50 μ s pulse
Number of surges	: 5 (at each phase)
Test mode	: Wireless mode
Result	: Complies

Measurement Data: AC POWER

Phase	Line	level	Result	Phase	Line	level	Result
0°	Line(L) to line(N)	+ 1 kV	Complies	90°	Line(L) to line(N)	+ 1 kV	Complies
		- 1 kV	Complies			- 1 kV	Complies
	Line(L) to ground(PE)	+ 2 kV	—		Line(L) to ground(PE)	+ 2 kV	—
		- 2 kV	—			- 2 kV	—
	Line(N) to ground(PE)	+ 2 kV	—		Line(N) to ground(PE)	+ 2 kV	—
		- 2 kV	—			- 2 kV	—
180°	Line(L) to line(N)	+ 1 kV	Complies	270°	Line(L) to line(N)	+ 1 kV	Complies
		- 1 kV	Complies			- 1 kV	Complies
	Line(L) to ground(PE)	+ 2 kV	—		Line(L) to ground(PE)	+ 2 kV	—
		- 2 kV	—			- 2 kV	—
	Line(N) to ground(PE)	+ 2 kV	—		Line(N) to ground(PE)	+ 2 kV	—
		- 2 kV	—			- 2 kV	—

TEST EQUIPMENT USED: 14, 15, 16, 40, 52, 53, 54, 55, 56, 57, 61

APPENDIX A

PERFORMANCE CRITERIA FOR IMMUNITY

The performance criteria are:

- performance criteria A for immunity tests with phenomena of a continuous nature;
- performance criteria B for immunity tests with phenomena of a transient nature;
- performance criteria C for immunity tests with power interruptions exceeding a certain time.

Table 1: Performance criteria

Criteria	During	After test
A	Shall operate as intended May show degradation of performance (see note 1) Shall be no loss of function Shall be no unintentional transmissions	Shall operate as intended Shall be no degradation of performance (see note 2) Shall be no loss of function Shall be no loss of stored data or user programmable functions
B	May show loss of function (one or more) May show degradation of performance (see note 1) No unintentional transmissions	Functions shall be self-recoverable Shall operate as intended after recovering Shall be no degradation of performance (see note 2) Shall be no loss of stored data or user programmable functions
C	May be loss of function (one or more)	Functions shall be recoverable by the operator Shall operate as intended after recovering Shall be no degradation of performance (see note 2)

NOTE 1: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

Performance criteria for Continuous phenomena applied to Transmitters (CT)**The performance criteria A shall apply:**

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied to Transmitters (TT)**The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply.**

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Continuous phenomena applied to Receivers (CR)**The performance criteria A shall apply.**

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied to Receivers (TR)**The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply.**

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

APPENDIX B

TEST EQUIPMENT AND ANCILLARIES USED FOR TESTS

To facilitate inclusion on each page of the test equipment used for related tests, each item of test equipment are identified by the Test Laboratory.

	Description	Model No.	Serial No.	Manufacturer	Interval	LAST Cal.
1	EMI TEST Receiver	ESCI7	100722	R&S	1 year	Sep-12
2	Two-Line V-Network <MAIN>	ENV216	100408	R&S	1 year	Sep-12
3	Two-Line V-Network <SUB>	ESH3-Z5	893045/017	R&S	1 year	Apr-12
4	RF Amplifier(-1GHz)	8447D	2944A07882	HP	2 year	Mar-12
5	Test Receiver(-30MHz)	ESHS10	828404/009	R&S	1 year	Mar-13
6	TRILOG Antenna	VULB 9160	9160-3172	SCHWARZBECK	2 year	Sep-12
7	Log.-Per. Antenna	VULP 9118	9118 A 401	SCHWARZBECK	2 year	Apr-11
8	Biconical Antenna	BBA 9106	VHA 9103-2315	SCHWARZBECK	2 year	Apr-11
9	Spectrum Analyzer (-2.9GHz)	8594E	3624A03649	HP	2 year	Mar-12
10	ESD Simulator	ESS-100L	6089C01173	Noiseken	1 year	Mar-13
11	Modula System	MODULA6100	34395	SCHAFFNER	1 year	Sep-12
12	EFT Clamp	CDN 8015	21240	SCHAFFNER	1 year	Sep-12
13	Lightning Surge Simulator	LSS-6030	LSS02X0153	NOISEKEN	1 year	Sep-12
14	Signal line Coupling Network	CDN 117	20985	SCHAFFNER	N/A	N/A
15	Signal line Coupling Network	CDN 118	20082	SCHAFFNER	N/A	N/A
16	Induction Coil	INA 702	132	SCHAFFNER	1 year	Apr-12
17	ELF Magnetic Field meter	4080	316	SYPRIS	1 year	Apr-12
18	HORN ANTENNA	3115	114105	ETS	2 year	Jan-12
19	Amplifier (1 - 18GHz)	8449B	3008A02126	Agilent	1 year	Mar-13
20	ABSORBING CLAMP	MDS21	3665	SCHWARZBECK	1 year	Sep-12
21	LOOP-ANTENNA	FMZB 1516	151602/94	SCHWARZBECK	2 year	Apr-11
22	V-NETWORK	ESH3-Z6	100378	R&S	1 year	Sep-12
23	Signal generator	SML03	103026/0013	R&S	1 year	Mar-13
24	NRVD POWER METER	NRVD	101689	R&S	1 year	Mar-13
25	Electric Field Sensor	HI-6005	79822	ETS-LINDGREN	1 year	Dec-12
26	Power Amplifier	CBA9433	T43646	SCHAFFNER	N/A	N/A
27	Power Amplifier	HD14919-25	1025	HD Communication Corp.	N/A	N/A
28	Log.-Per.Antenna (70M - 1.8GHz)	VULP 9118E	9118E-812	SCHWARZBECK	1 year	Apr-12
29	RF-Power-Amplifier	FLL75A	1033	FRANKONIA	N/A	N/A
30	CDN (M1,2,3 etc)	TSCDN	-	F.C.C	1 year	Sep-12
31	EM INJECTION CLAMP (10K - 1GHz)	TSIC-23	529	F.C.C	1 year	May-12
32	EZ-17 RF-CURRENT PROBE	EZ-17	100508	ROHDE&SCHWARZ	1 year	Jan-13
33	PM6000 Universal Power Analyzer	PM6000	100006700108	Voltech Instruments	2 year	Apr-12
34	Reference Impedance Network	ES4152	9074424	NF Corp.	2 year	Mar-13

	Description	Model No.	Serial No.	Manufacturer	Interval	LAST Cal.
35	Signal Generator	8648C	3623A02597	HP	1 year	Mar-13
36	Attenuator (3dB)	8491A	37822	HP	1 year	Sep-12
37	Attenuator (10dB)	8491A	63196	HP	1 year	Sep-12
38	Hygro-Thermograph	THB-36	0041557-01	ISUZU	1 year	Sep-12
39	Mini-Circuits Splitter	ZFSC-2-2500	SF617800326	Mini-Circuits	N/A	N/A
40	Mini-Circuits Splitter	ZFM-150	15542	Mini-Circuits	N/A	N/A
41	Pulse Limiter	ESH3-Z2	100710	R&S	1 year	Mar-13
42	RF AMPLIFIER(~1.3GHz)	8447D OPT 010	2944A07684	HP	1 year	Sep-12
43	e3 software	e3	5.5.201a	AUDIX	-	-
44	Impedance Stabilization Network	ISN T800	27109	TESEQ	1 year	Jan-13
45	Impedance Stabilization Network	ENY81-CA6	101565	R&S	1 year	Jan-13
46	Decoupling clamp Luthi	FTC40X15E	5637	Luthi	N/A	N/A
47	STEP TRANSFORMER	INA6502	34270	SCHAFFNER	1 year	Sep-12
48	R-BOX (4x100OHM)	INA 172	SL403-109	SCHAFFNER	N/A	N/A
49	R-BOX (4x160OHM)	INA 175	SL403-474	SCHAFFNER	N/A	N/A
50	Coupling Accessory with 0.1uF (5ea)	INA 171	SL403-108	SCHAFFNER	N/A	N/A
51	Coupling Accessory (5ea)	INA 170	SL403-107	SCHAFFNER	N/A	N/A
52	Coupling Accessory 0.5uF (1ea)	INA 174	SL403-209	SCHAFFNER	N/A	N/A
53	Short Circuit Plug	INA 173	403-110	SCHAFFNER	N/A	N/A
54	CS software	TEPTO-S6	2.6.8	TSJ corp.	N/A	N/A
55	RS software	TEPTO-RS	4.7.7	TSJ corp.	N/A	N/A
56	Harmonic-Fliker software	PM6000	1.03.02	Voltech	N/A	N/A
57	EMS software	WIN Modula	2.31c	SCHAFFNER	N/A	N/A
58	EFT Simulator	FNS-AX2	4000B01332	NoiseKen	1 year	Sep-12
59	DIGITAL THERMO HYGROMETER	DHT-1	12103	DYS	1 year	Oct-12
60	DIGITAL THERMO HYGROMETER	DHT-1	12104	DYS	1 year	Oct-12
61	DIGITAL THERMO HYGROMETER	DHT-1	12105	DYS	1 year	Oct-12
62	DIGITAL THERMO HYGROMETER	DHT-1	12106	DYS	1 year	Oct-12
63	EFT software	STANDARD MODULE 2 ST-017	1.01	(C)NOISE LABORATORY CO.,LTD	N/A	N/A

APPENDIX C

Measurement Uncertainty

1. Conducted Emission

2. Radiated Emission

1. Conducted Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)	Standard
		9 kHz – 30 MHz	
Cable loss(RG400)	Standard Deviation(SD)	± 0.061	10 th measurement
Receiver corrections; -Sine wave voltage -Pulse amplitude response -Pulse repetition rate response	Rectangular ($\sqrt{3}$) Rectangular ($\sqrt{3}$) Rectangular ($\sqrt{3}$)	± 0.17 ± 0.02 ± 0.58	Cal. Report Cal. Report Cal. Report
LISN corrections (ENV216) ; -Voltage division factor	Normal (k = 2)	± 0.09	Cal. Report
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -LISN VRC : $\Gamma_g = 0.14(150\text{kHz})$ = 0.05(30MHz) - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type($\sqrt{2}$)	± 0.89	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.28	10 th measurement
Combined measurement uncertainty Uc(y)	Normal	+ 0.73 - 0.73	
Expended measurement uncertainty (95%,Confidence level,k = 2)dB	Normal(k = 2)	+ 1.46 - 1.46	

2.Below 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)		Standard
		Trilog		
		3m	10m	
Antenna Factor (VULB 9160)	Normal (k = 2)	30 M – 1 GHz	30 M – 1 GHz	ANT Cal. uncertainty
		± 2.00	± 2.00	
Cable loss (HFB-5010/HFC12D)	Standard Deviation(SD)	± 0.14	± 0.14	10 th measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2)	± 0.17	± 0.17	Cal. Report Cal. Report CISPR16-4-2
	Normal (k = 2)	± 0.58	± 0.58	
	Rectangular(√ 3)	± 1.50	± 1.50	
Antenna Directivity	Rectangular(√ 3)	± 1.00	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular(√ 3)	± 0.10	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular(√ 3)	± 0.20	± 0.20	CISPR16-4-2
Separation Distance	Rectangular(√ 3)	± 0.30	± 0.30	CISPR16-4-2
Uncertainty of Site	Triangular(√ 6)	± 2.97	± 2.97	NSA
Mismatch ; - Receiver VRC* : Γi = 0.09 -ANT. VRC : Γg = 0.09 - Uncertainty: 20log(1± Γi Γg)	U-type (√ 2)	± 0.54	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.14	± 0.14	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.60	± 0.60	10 th measurement
Combined measurement uncertainty Uc(y)	Normal	+ 1.97 - 1.97	+ 1.97 - 1.97	
Expended measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	30 M – 1 GHz + 3.94 - 3.94	30 M – 1 GHz + 3.94 - 3.94	

Note:VRC(Voltage Reflection Coefficient)

3. Above 1 GHz Radiated Emission

Input Quantity	Probability Distribution	Probability Distribution (dB)	Standard
		HORN	
Antenna Factor (ETS 3115)	Normal (k=2) (normal)	1 GHz - 6 GHz ± 1.00	ANT Cal. uncertainty
Cable loss (SUHNER MULTIFLEX microwave cables)	Standard Deviation(SD)	± 0.32	10 th measurement
Receiver corrections; -Sine Wave Voltage -Pulse amplitude response -Pulse repetition rate response	Normal (k = 2) Normal (k = 2) Rectangular($\sqrt{3}$)	± 0.17 ± 0.58 ± 1.50	Cal. Report Cal. Report CISPR16-4-2
Antenna Directivity	Rectangular($\sqrt{3}$)	± 1.00	CISPR16-4-2
AF Height Dependence	Rectangular($\sqrt{3}$)	± 0.10	CISPR16-4-2
Phase Center Location	Rectangular($\sqrt{3}$)	± 0.20	CISPR16-4-2
Separation Distance	Rectangular($\sqrt{3}$)	± 0.30	CISPR16-4-2
Uncertainty of Site	Standard Deviation(SD)	± 0.13	SVSWR 10 th measurement
Mismatch ; - Receiver VRC* : $\Gamma_i = 0.09$ -ANT. VRC : $\Gamma_g = 0.09$ - Uncertainty: $20\log(1 \pm \Gamma_i \Gamma_g)$	U-type ($\sqrt{2}$)	± 0.54	CISPR16-4-2
Pre-amp.	Normal (k = 2)	± 0.60	Cal. Report
System Repeatability	Standard Deviation(SD)	± 0.34	10 th measurement
Combined measurement uncertainty Uc(y)	Normal	+ 1.73 - 1.73	
Expended measurement uncertainty (95%,Confidence level,k=2)dB	Normal(k = 2)	1 GHz - 6 GHz + 3.46 - 3.46	

Note:VRC(Voltage Reflection Coefficient)

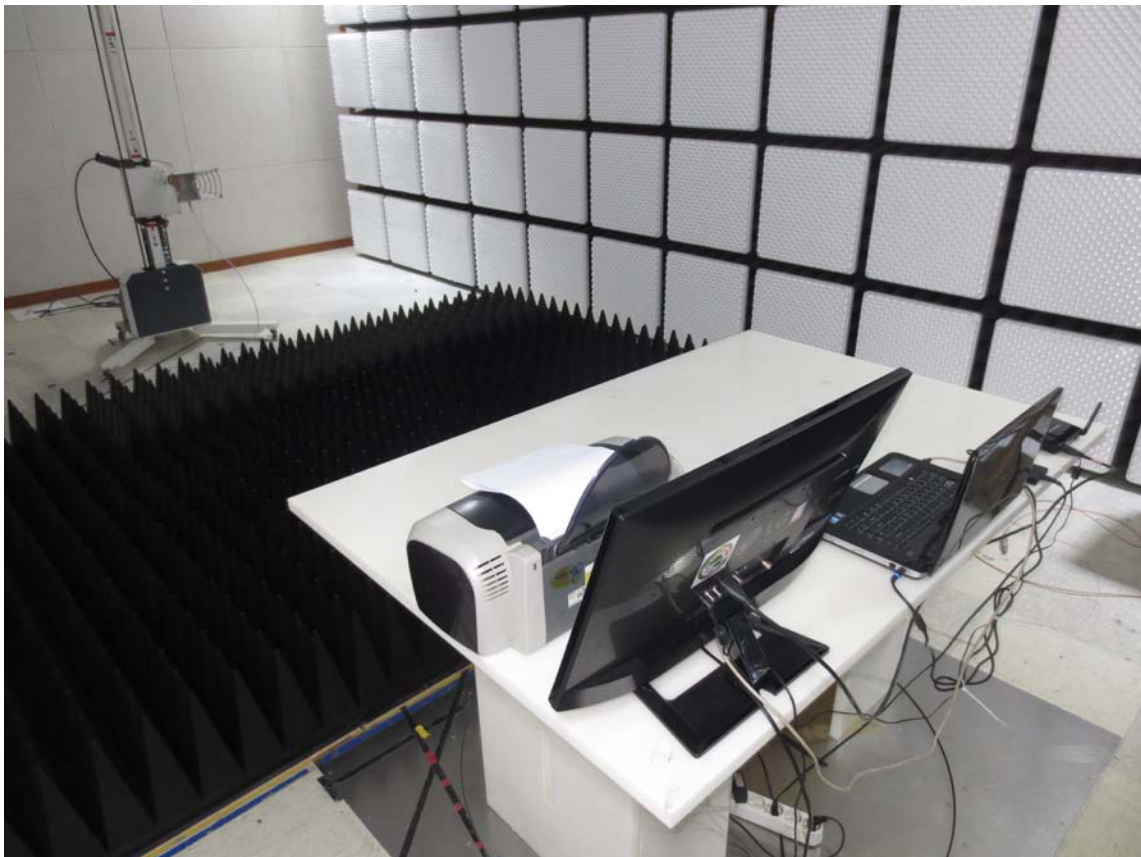
APPENDIX D

PHOTOGRAPHS

Radiated emission (Maximum emission configuration) – Below 1GHz



Radiated emission (Maximum emission configuration) – Above 1GHz



Conducted emission (Maximum emission configuration)



Electrostatic Discharge



Radio Frequency Electromagnetic field



Fast Transients Common mode



Radio Frequency common mode



Voltage dips and Interruptions



Surges

